Notice of References Cited

Application/Control No.

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Examiner

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Applicant(s)/Patent Under
Reexamination
DUFFY ET AL.

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0107390	05-2005	Brockunier et al.	514/249
*	В	US-2006/0270679	11-2006	Edmondson et al.	514/249
*	С	US-7,125,873	10-2006	Edmondson et al.	514/249
*	D	US-2007/0099884	05-2007	Erondu et al.	514/183
*	Ε	US-2006/0270722	11-2006	Thornberry et al.	514/374
*	F	US-2006/0287528	12-2006	Wenslow et al.	544/350
*	G	US-2005/0032804	02-2005	Cypes et al.	514/249
*	Н	US-2007/0021430	01-2007	Chen et al.	514/249
*	1	US-6,699,871	03-2004	Edmondson et al.	514/249
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	Ο.			•		
	Р					
	Q					33 1 11
	R				·	
	S					
	Т			·		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	ט	Kim et al., J. Med Chem, 2005, 48, 141-151
	٧	
	W	,
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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